

Notice of References Cited	Application/Control No. 10/525,706	Applicant(s)/Patent Under Reexamination KIM ET AL.	
	Examiner Luan V. Van	Art Unit 1753	Page 1 of 1

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*	C	US-6,709,929	03-2004	Zhang et al.	438/268
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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